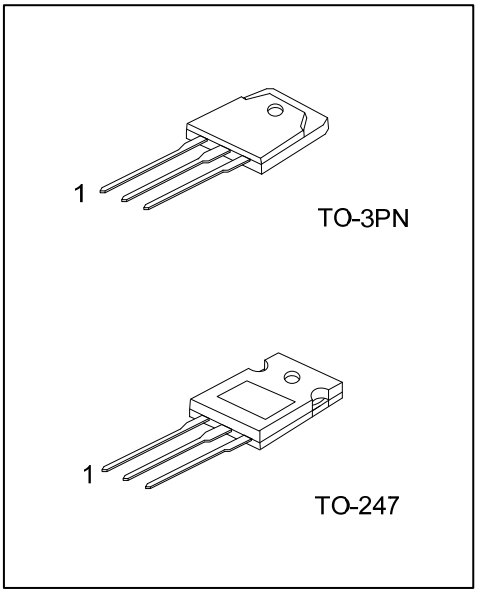
UTG30N135ND-S

Preliminary ***Insulated Gate Bipolar Transistor***

1350V TRENCH GATE FIELD-STOP IGBT



■ DESCRIPTION

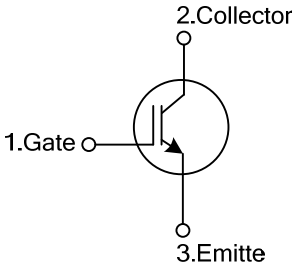
The UTC **UTG30N135ND-S** is an Trench Field-Stop Insulated Gate Bipolar Transistor. it uses UTC's advanced technology to provide customers with high switching speed, low saturation voltage and low switching loss, etc.

The UTC **UTG30N135ND-S** is suitable for the resonant or soft switching applications.

■ FEATURES

* High switching speed
* High avalanche ruggedness
* Low saturation voltage: $V_{CE(SAT).Typ.}$ =1.67V @ I_C=30A, V_{GE}=15V (T_C =25°C)

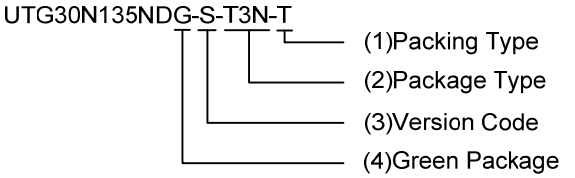
■ SYMBOL



■ ORDERING INFORMATION

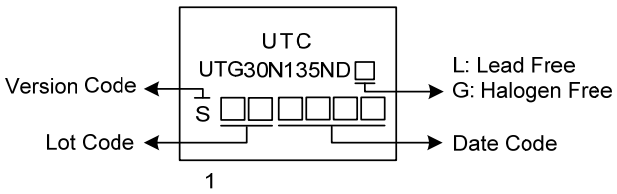
Ordering Number		Package	Pin Assignment			Packing
Lead Free	Halogen Free		1	2	3	
UTG30N135NDL-S-T3N-T	UTG30N135NDG-S-T3N-T	TO-3PN	G	C	E	Tube
UTG30N135NDL-S-T47-T	UTG30N135NDG-S-T47-T	TO-247	G	C	E	Tube

Note: Pin Assignment: G: Gate C: Collector E: Emitter



(1) T: Tube
(2) T3N: TO-3PN, T47: TO-247
(3) Version S
(4) G: Halogen Free and Lead Free, L: Lead Free

■ MARKING



■ ABSOLUTE MAXIMUM RATINGS (T_A=25°C, unless otherwise specified)

PARAMETER		SYMBOL	RATINGS	UNIT
Collector-Emitter Voltage		V_{CES}	1350	V
Gate-Emitter Voltage		V_{GES}	±20	V
Transient Gate-emitter voltage (t_P < 5 ms)			±25	V
Continuous Collector Current	T_C=25°C	I_C	60	A
	T_C=100°C		30	A
Collector Current Pulsed (Note 1)		I_{CM}	120	A
Short Circuit Withstand Time V_{GE} = 15V, V_{CC} ≤ 200V Allowed number of short circuits < 1000 Time between short circuits: ≥ 1.0s T_{VJ} = 25°C		t_{SC}	10	μs
Power Dissipation (T_C=25°C)	TO-3PN	P_D	270	W
	TO-247		245	W
Operating Junction Temperature		T_J	-40 ~ +150	°C
Storage Temperature Range		T_{STG}	-55 ~ +150	°C

Notes: 1. Absolute maximum ratings are stress ratings only and functional device operation is not implied. Absolute maximum ratings are those values beyond which the device could be permanently damaged.
2. Pulse width limited by maximum junction temperature.

■ THERMAL DATA

PARAMETER		SYMBOL	RATING	UNIT
Junction to Case	TO-3PN	$θ_{JC}$	0.46	°C/W
	TO-247		0.51	°C/W

■ ELECTRICAL CHARACTERISTICS (T_C=25°C, unless otherwise specified)

PARAMETER	SYMBOL	TEST CONDITIONS		MIN	TYP	MAX	UNIT
OFF CHARACTERISTICS							
Collector-Emitter Breakdown Voltage	BV_{CES}			1350			V
Collector Cut-Off Current	I_{CES}	V_{CE}=1350V, V_{GE}=0V				250	μA
G-E Leakage Current	I_{GES}	V_{CE}=0V, V_{GE}=±20V				±250	nA
On CHARACTERISTICS							
Gate to Emitter Threshold Voltage	$V_{GE(TH)}$	I_C=250μA, V_{CE}=V_{GE}		4.5		6.5	V
Collector to Emitter Saturation Voltage	$V_{CE(SAT)}$	I_C=30A, V_{GE}=15V	T_C=25°C		1.67	2.1	V
			T_C=125°C		2.0		V
DYNAMIC CHARACTERISTICS							
Input Capacitance	C_{IES}	V_{CE}=25V, V_{GE}=0V, f=1MHz			2910		pF
Output Capacitance	C_{OES}				81		pF
Reverse Transfer Capacitance	C_{RES}				30.5		pF
SWITCHING CHARACTERISTICS							
Turn-On Delay Time	$t_{DON)}$	V_{CC}=600V, I_C=30A, R_G=5Ω, V_{GE}=0~15V, L=500μH			24.9		ns
Rise Time	t_R				30.1		ns
Turn-Off Delay Time	$t_{DOFF)}$				110.6		ns
Fall Time	t_F				257.6		ns
Turn-On Switching Loss	E_{ON}				2.08		mJ
Turn-Off Switching Loss	E_{OFF}				2.4		mJ